

<b>Notice of References Cited</b>	Application/Control No. 10/655,095	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Edgardo San Martin	Art Unit 2837	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,603,859	08-2003	Asano, Michihiro	381/59
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 63036698 A	02-1988	Japan	KURITA et al.	H04R 01/32
	O	JP 62269597 A	11-1987	Japan	SAKAI, SHINICHI	H04R 01/32
	P	JP 62018898 A	01-1987	Japan	KASHIMOTO et al.	H04R 05/02
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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